

R&S®RTM3000 Oscilloscope At a glance

Designed as an everyday problem solving tool, the R&S®RTM3000 combines the power of ten (10-bit ADC, 10 times the memory and 10.1" touchscreen) with a Rohde & Schwarz probe interface for use with all Rohde & Schwarz probes.

Rohde & Schwarz stands for quality, precision and innovation in all fields of wireless communications. As an independent, family-owned company, Rohde & Schwarz finances its growth from its own funds. The company plans for the long term to the benefit of its customers. Purchasing Rohde & Schwarz products is an investment for the future.

The display, which is the largest capacitive display (10.1") with the highest resolution (1280 \times 800 pixel) in its class, works just like your smartphone. Simply touch the screen to quickly navigate in pop-up menus and use gesturing to easily scale, zoom and move a waveform.

The 10-bit A/D converter yields up to a fourfold improvement over conventional 8-bit A/D converters. You get sharper waveforms with more signal details.

40 Msample memory depth is available on each channel as soon as all channels are active. When interleaved, 80 Msample are available to capture longer signal sequences for more analysis results.

With the Rohde&Schwarz probe interface, all Rohde&Schwarz probing solutions can be used – for perfect connections to any DUT.

The R&S®RTM3000 provides users with more than just an oscilloscope. It includes a logic analyzer, protocol analyzer, waveform and pattern generator, digital voltmeter. Dedicated operating modes for frequency analysis, mask tests and long data acquisitions are integrated. You can quickly and efficiently debug all kinds of electronic systems – and the R&S®RTM3000 satisfies the all-important rule of investment protection at a very attractive price.



Benefits

See small signal details in the presence of large signals

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The right probe for the best measurement

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	R&S®RTC1000	R&S®RTB2000	R&S®RTM3000	R&S®RTA4000
Number of oscilloscope channels	2	2/4	2/4	4
Bandwidth in MHz	50, 70, 100, 200, 300	70, 100, 200, 300	100, 200, 350, 500, 1000	200, 350, 500, 1000
Max. sampling rate in Gsample/s	1/channel, 2 interleaved	1.25/channel, 2.5 interleaved	2.5/channel, 5 interleaved	2.5/channel, 5 interleaved
Max. memory depth in Msample	1/channel, 2 interleaved	10/channel, 20 interleaved; 160 Msample (optional) segmented memory	40/channel, 80 interleaved; 400 Msample (optional) segmented memory	100/channel, 200 interleaved, 1 Gsample (standard) segmented memory
Timebase accuracy in ppm	50	2.5	2.5	0.5
Vertical bits (ADC)	8	10	10	10
Min. input sensitivity	1 mV/div	1 mV/div	500 μV/div	500 μV/div
Display	6.5", 640 × 480 pixel	10" capacitive touch, 1280 × 800 pixel	10" capacitive touch, 1280 × 800 pixel	10" capacitive touch, 1280 × 800 pixel
Update rate	10 000 waveforms/s	300 000 waveforms/s in fast segmentated memory mode	2 000 000 waveforms/s in fast segmentated memory mode	2 000 000 waveforms/s in fast segmentated memory mode
MSO	8 channels, 1 Gsample/s	16 channels, 2.5 Gsample/s	16 channels, 5 Gsample/s	16 channels, 5 Gsample/s
Protocol (optional)	I ² C, SPI, UART/RS-232/ RS-422/RS-485, CAN, LIN	I ² C, SPI, UART/RS-232/ RS-422/RS-485, CAN, LIN	I ² C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN, audio (I ² S/ LJ/RJ/TDM), ARINC, MIL	I ² C, SPI, UART/RS-232/ RS-422/RS-485, CAN, LIN, audio (I ² S), ARINC, MIL
Generator(s)	1 generator, 4-bit pattern generator	1 ARB, 4-bit pattern generator	1 ARB, 4-bit pattern generator	1 ARB, 4-bit pattern generator
Math	+,-,*,/,FFT(128k points)	+,-,*,/,FFT(128k points)	+, -, *, /, FFT (128k points), 21 advanced functions	+,-,*,/,FFT(128k points), 21 advanced functions
Rohde&Schwarz probe interface	-	_	standard	standard
RF capability	FFT	FFT	spectrum analysis 1)	spectrum analysis 1)

 $^{^{\}mbox{\tiny 1)}}$ The R&S*RTM-K18 and R&S*RTA-K18 options are not distributed in North America.

See small signal details in the presence of large signals

10-bit ADC: 1024 levels, 4 times more

than 8-bit ADC

500 μV/div: full bandwidth, no software magnification

10-bit vertical resolution

The R&S®RTM3000 features a customized Rohde&Schwarz designed 10-bit A/D converter that delivers a fourfold improvement over conventional 8-bit A/D converters.

The increased resolution results in sharper waveforms with more signal details that would otherwise be missed. One example is the characterization of switched-mode power supplies. The voltages across the switching device must be determined during the on/off times within the same acquisition. For precise measurements of small voltage components, a high resolution of more than 8 bit is essential.

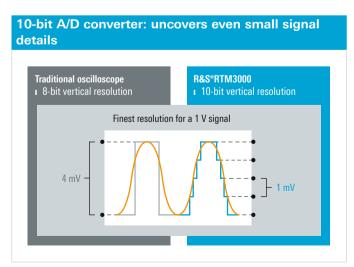
500 μ V/div: full measurement bandwidth and low noise

The R&S°RTM3000 oscilloscope offers outstanding sensitivity down to 500 $\mu\text{V/div}.$ Traditional oscilloscopes can only reach this level of input sensitivity by employing software-based magnification or by limiting the bandwidth. The R&S°RTM3000 oscilloscope shows the signal's real sampling points over the full measurement bandwidth – even at 500 $\mu\text{V/div}.$ This ensures high measurement accuracy.

The accuracy of the signal displayed on the screen depends on the oscilloscope's inherent noise. The R&S®RTM3000 oscilloscope precisely measures even at the smallest vertical resolution by using low-noise frontends and state-of-the-art A/D converters.

The Rohde&Schwarz designed 10-bit A/D converter ensures highest signal fidelity at highest resolution





Capture more time at full bandwidth

80 Msample: standard acquisition memory 8 to 40 times better

5 Gsample:

fast sampling rate

400 Msample:

segmented memory



40 Msample standard and 80 Msample interleaved

The R&S®RTM3000 offers a class-leading memory depth: 40 Msample per channel, and even 80 Msample in interleaved mode. This is eight times more than similar oscilloscopes in the same instrument class. It captures longer acquisition sequences even at high sampling rates for more analysis results, e.g. when analyzing transients of switched-mode power supplies.

Capture and analyze pulsed and burst signals over a long period; 400 Msample deep segmented memory is unique in this class



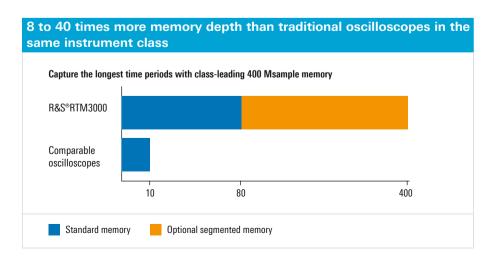
Segmented memory: 400 Msample with history **function**

The R&S®RTM-K15 option with deep, segmented memory analyzes signal sequences over a long observation period. For example, protocol-based signals with communications gaps, such as I²C and SPI, can be captured over several seconds or minutes. Thanks to the variable segment size from 10 ksample to 80 Msample, the 400 Msample memory is optimally utilized; more than 34000 cohesive individual recordings are possible.

In history mode, previous acquisitions to the maximum segmented memory depth of 400 Msample are available for further analysis. Functions such as mask tests, QuickMeas and FFT can be used for further analysis.

Maintains fast sampling rates at all times

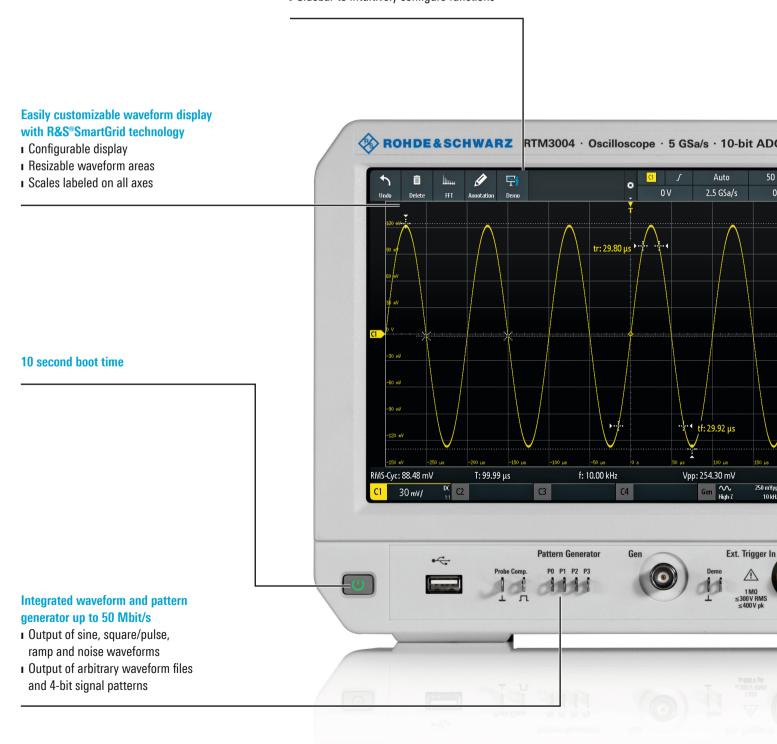
Signal faults and important events are detected better with an oscilloscope that offers a high sampling rate. Many applications require long acquisition cycles, for instance when analyzing serial protocols. With a sampling rate of up to 5 Gsample/s and a memory depth of up to 80 Msample, the R&S®RTM3000 oscilloscopes really excel here. They accurately display signals, right down to the details, over long sequences.



10.1" high-resolution capacitive touchscreen v

Quick access to important tools

- Drag & drop to use analysis tools
- Toolbar to access functions
- Sidebar to intuitively configure functions



vith gesture support

10.1" high-resolution capacitive touchscreen with gesture support

- Gesture support for scaling and zooming
- $\scriptstyle I$ High resolution: 1280 \times 800 pixel
- 1 12 horizontal grid lines for more signal details

Documentation of results at the push of a button

Documentation as a screenshot or of instrument settings

Run Sample Trigger Source Source Touch Lock Touch Lock

Integrated logic analyzer (MSO)

- 1 16 additional digital channels
- Synchronous and time-correlated analysis of analog and digital components of embedded designs
- Fully retrofittable

Color-coded controls indicate the selected channel

QuickMeas: results at the push of a button

 Graphical display of key measurement results for the active signal



Active probe interface

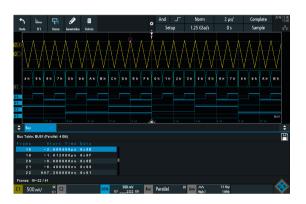
- Automatically detects and powers probes
- Rohde & Schwarz probes with probe interface
- More than 30 available probes

X-in-1 oscilloscope



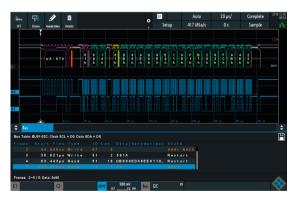
Oscilloscope

With a sampling rate of up to 5 Gsample/s and a memory depth of up to 80 Msample, the R&S®RTM3000 oscilloscope excels in its class. A waveform update rate of more than 64 000 waveforms/s ensures a responsive instrument that reliably catches signal faults. Included tools provide quick results, e.g. QuickMeas, mask tests, FFT, math, cursors and automatic measurements (including statistics).



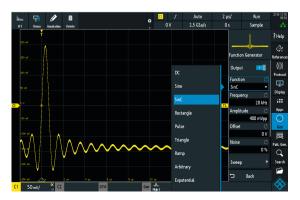
Logic analyzer

The R&S®RTM-B1 option turns every R&S®RTM3000 into an intuitive-to-use MSO with 16 additional digital channels. The oscilloscope captures and analyzes signals from analog and digital components of an embedded design – synchronously and time-correlated to each other. For example, the delay between input and output of an A/D converter can conveniently be determined using the cursor measurements.



Protocol analyzer

Protocols such as I²C, SPI and CAN/LIN frequently transfer control messages between integrated circuits. The R&S®RTM3000 has versatile options for protocol-specific triggering and decoding of serial interfaces. Selective acquisition and analysis of relevant events and data is possible. With the hardware-based implementation, smooth operation and a high update rate are ensured even for long acquisitions. This is advantageous, for example, for capturing multiple packetized serial bus signals.

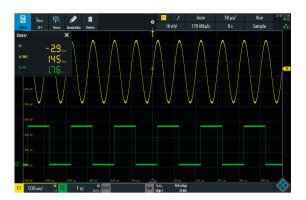


Waveform and pattern generator

The integrated R&S®RTM-B6 waveform and pattern generator (up to 50 Mbit/s) is useful for educational purposes and for implementing prototype hardware. In addition to common sine, square/pulse, ramp and noise waveforms, it outputs arbitrary waveforms and 4-bit signal patterns. Waveforms and patterns can be imported as CSV files or copied from oscilloscope waveforms. You can preview signals before playing them back to quickly check signal correctness. Predefined patterns for e.g. I²C, SPI, UART and CAN/LIN are provided.

Videos





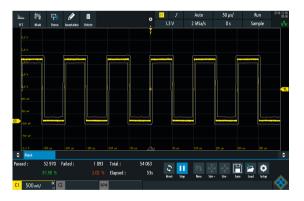
Digital voltmeter

For simultaneous measurements, the R&S®RTM3000 features a 3-digit voltmeter (DVM) and 6-digit frequency counter on each channel. Measurement functions include DC, AC + DC (RMS) and AC (RMS).



Frequency analysis mode

Difficult-to-find faults often result from the interaction between time and frequency signals. The FFT function of the R&S®RTM3000 is activated at the push of a button and by entering center frequency and span. Thanks to the R&S®RTM3000 oscilloscopes' high-performance FFT functionality, signals can be analyzed with up to 128k points. Other tools include cursor measurements and autoset in the frequencv domain.



Mask test mode

Mask tests quickly reveal whether a specific signal lies within defined tolerance limits. Masks assess the quality and stability of a DUT based on statistical pass/fail evaluation. Signal anomalies and unexpected results are quickly identified. When the mask is violated, the measurement stops. Each violation can generate a pulse output at the AUX-OUT connector on the R&S®RTM3000. This pulse output can be used to trigger actions in the measurement setup.



History and segmented memory mode

The R&S®RTM-K15 history and segmented memory option increases the memory from 40 Msample to 400 Msample. You can scroll through past acquisitions and analyze the data using the oscilloscope tools, e.g. protocol decode and logic channels. Serial protocol and pulse sequences are recorded practically without interruptions.

Frequency response analysis (Bode plot)

- I Analyze the frequency response of passive filters and amplifier circuits
- **Perform control loop response measurements**
- ı Perform power supply rejection ratio measurements
- **I** Simple and fast documentation

Perform low-frequency response analysis with an oscilloscope

The R&S®RTM-K36 frequency response analysis (Bode plot) option lets you perform low-frequency response analysis on your oscilloscope easily and quickly. It characterizes the frequency response of a variety of electronic devices, including passive filters and amplifier circuits. For switch mode power supplies, it measures the control loop response and power supply rejection ratio. The frequency response analysis option uses the oscilloscope's built-in waveform generator to create stimulus signals ranging from 10 Hz to 25 MHz. Measuring the ratio of the stimulus signal and the output signal of the DUT at each test frequency, the oscilloscope plots gain and phase logarithmically.



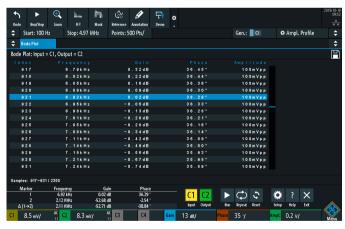
The R&S®RTM-K36 frequency response analysis (Bode plot) option characterizes the frequency response of a variety of electronic devices, including passive filters and amplifier circuits



The amplitude output level of the generator signal can be varied during the measurement to suppress the noise behavior of the DUT



The measurement resolution can be varied by changing the points per decade



A table of measurement results provides detailed information about each measurement point, consisting of frequency, gain and phase shift



Features and functionalities

Amplitude profile

The R&S®RTM-K36 frequency response analysis (Bode plot) option allows users to profile the amplitude output level of the generator. This helps to suppress the noise behavior of the DUT when performing a control loop response or power supply rejection ratio and to improve signal-to-noise ratio (SNR). It is possible to define up to 16 steps.

Improve resolution and markers support

You can choose the points per decade to set up and modify the resolution of your plot. The oscilloscope supports up to 500 points per decade. Markers can be dragged to the desired position, directly on the plotted trace. A legend displays the corresponding coordinates of the markers. To determine the crossover frequency, set one marker to 0 dB and the second marker to –180° phase shift. Now you can easily determine the phase and gain margin.

Measurement table

Furthermore, you can view the results in a table. The table of measurement results details information about each measured point, consisting of frequency, gain and phase shift. In case you use cursors, for ease of use, the associated row of the result table is highlighted. For reporting, screenshots, table results or both can be quickly saved to a USB device.

Broad probe portfolio

Accurate control loop response or power supply rejection ratio characterization highly depends on choosing the right probes, since peak-to-peak amplitudes of both $V_{\rm in}$ and $V_{\rm out}$ can be very low at some test frequencies. These values would be buried in the oscilloscope's noise floor and/or in the switching noise of the DUT itself. We recommend the low-noise R&S*RT-ZP1X 38 MHz bandwidth 1:1 passive probes. These reduce measurement noise and provide the best SNR.

The best choice for power

- I Analyze the input, output and transfer function of switched-mode power supplies
- ı Measurement wizard for fast results
- I Simple and fast documentation
- I Analyze harmonic current in line with conventional EN, MIL and RTCA standards

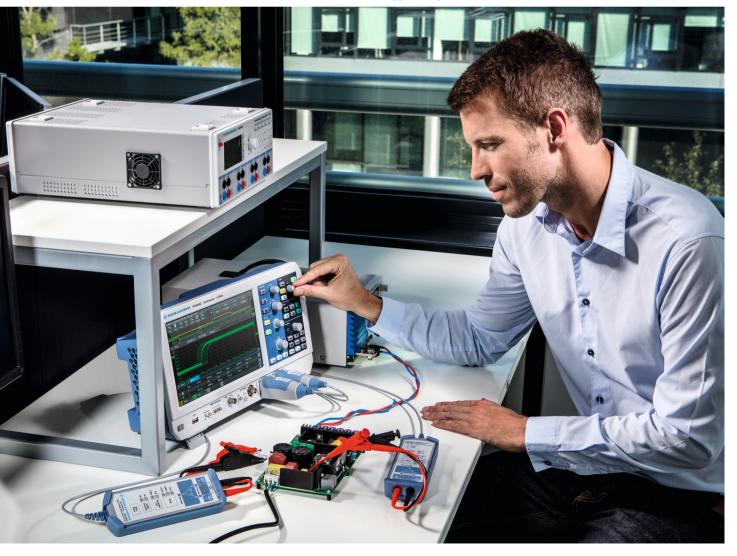
See power signal details with up to 10-bit resolution

Even the smallest signal details of a high dynamic signal matter for power measurements. Verification of $R_{\rm DS(on)}$ of a MOSFET is one example. The high ADC resolution of the R&S°RTM3000 oscilloscopes increases the vertical resolution up to 10 bit. Previously unseen signal details become visible and measurable. In the $R_{\rm DS(on)}$ example, this makes it possible to measure the slope of the drain-to-source-voltage while the switch is closed.

Complete probe portfolio for power measurements

Accurate voltage and current probes with a suitable measurement range are critical for power measurements. Rohde & Schwarz offers a complete probe portfolio for different power measurement applications – ranging from μA to μA and from μV to μV .





Specialized measurement functions for characterizing power electronics

Analysis tools support verification and debugging when developing current and voltage supply circuits. The R&S®RTM-K31 power analysis option facilitates analysis of the turn on/off behavior, the internal transfer function of the overall circuit, the safe operating area (SOA), the output signal quality and any loss.

Standards for limiting the harmonic current

Depending on the application, different standards for limiting the harmonic current must be met when developing switched-mode power supplies. The R&S®RTM-K31 option supports the user during testing of all conventional standards: EN 61000-3-2 classes A, B, C, D, MIL-STD-1399 and RTCA DO-160.

Easy, clear documentation of power analysis

Results can be added to the test report simply by pressing a button. This report documents the current setup and configuration. The R&S®Oscilloscope Report Creator is used to generate a report (available free of charge on the Rohde&Schwarz website). You can define the level of detail for the report and customize the layout, for example, by adding a company logo. The output format is .pdf.

Measurement f	Measurement functions of the R&S®RTM-K31 option		
Measurement	Measurement functions		
Current harmonics	I EN 61000-3-2 class A, B, C, DI MIL-STD-1399I RTCA DO-160		
Input	i inrush currentpower qualitypower consumption		
Power converter control	I modulation analysisI slew rateI dynamic on-resistance		
Power path	 I safe operating area (SOA mask editor) I turn on/off I switching loss I power efficiency 		
Output	output rippletransient responseoutput spectrum		



Online help facilitates quick and easy testing

Spectrum analysis: identify interactions between time and frequency

Spectrogram: evolution over time

Peak markers:

automatic positioning



Fast and precise analysis

Difficult-to-find faults often result from the interaction between time and frequency signals. The R&S®RTM-K18¹¹ spectrum analysis and spectrogram option quickly finds such errors. Like on a spectrum analyzer, parameters such as center frequency and resolution bandwidth can be adapted to the specific measurement task. The oscilloscope automatically selects the relevant time domain settings. Optimum performance ensures the fastest multidomain analysis in this oscilloscope class.

1) The R&S®RTM-K18 option is not distributed in North America.

Parallel operation: correlation between frequency and time

Advanced electronics is based on the seamless interaction between protocol-based interfaces, digital, analog and frequency components. Simultaneous analysis of all components is a must. Time, frequency and protocol information are correlated, and time references can be quickly recognized. Measurement windows help you select specific areas of the recording, which can simplify, for example, the acquisition of frequency switching operations.

Spectrogram: display of frequency over time

A spectrogram displays the spectrum of frequencies as they vary over time. For easy interpretation, the magnitude can be color-coded. Thanks to the high FFT rate, even fast frequency changes can be displayed. When used in combination with the R&S°RTM-K15 history and segmented memory option, the spectrogram marker shows the time of the acquisition and makes it possible to load the corresponding time and frequency waveforms onto the screen. All R&S°RTM3000 tools can be used to analyze the loaded waveforms.

Markers: find peaks automatically

Markers can be automatically positioned on the frequency peaks for fast analysis. An adaptable threshold defines the peaks. Parameters such as excursion and maximum peak width can be adjusted for in-depth analysis. Results can be compiled in a table (absolute or relative to a specific reference marker). Selectable delta measurements make it easy to adjust the distances between signal peaks.



Test signal from three different perspectives: time domain (top), spectrogram (center) and frequency domain (bottom)

Protocol analysis: efficiently debug serial buses



Protocol aware triggering and decoding for serial buses

Counting 1s and 0s to decode a serial bus is tedious and error-prone. The R&S®RTM3000 automates this process by decoding the waveforms into a specific protocol. In addition, protocol aware triggering directly triggers on specific parts of a packet or frame.

Segmented memory for long time captures

Standard segmented memory is ideal for serial protocols. It allows you to capture only relevant packets/frames and ignore the long idle time in between packets. With more than 400 Msample of segmented memory available, you can capture more than 34 000 timestamped packets/frames.

Table view of packets/frames

A table view allows you to see a high-level representation of all captured packets. You can also export the table.

Supported buses	
Embedded	I I ² C I UART/RS-232/RS-422/RS-485 I SPI (2/3/4-wire)
Aerospace	■ MIL-STD-1553 ■ ARINC 429
Automotive, industrial	ı CAN ı LIN
Audio	ı I ² S/LJ/RJ/TDM



Decoded hexadecimal I²C message shown in honeycomb format and in table

The right probe for the best measurement

More than 30: dedicated probes

Micro button: for convenient

instrument control

0.01% accuracy: with

R&S®ProbeMeter

Extensive probe range for all measurement tasks

A complete portfolio of high-quality passive and active probes covers all measurement tasks. With an input impedance of 1 M Ω , the active probes put only a minimum load on a signal source's operating point. The very large dynamic range, even at high frequencies, prevents signal distortion – for example: 60 V (V $_{pp}$) at 1 GHz for the active single-ended probes.

Complete portfolio for power measurements

The portfolio of dedicated probes for power measurements includes active and passive probes for the different voltage and current ranges – from μA to kA and from μV to kV. Dedicated power rail probes detect even small and sporadic distortions on DC power rails.

Micro button for convenient instrument control

The situation is all too familiar. You've carefully positioned the probe on the device under test and want to start measurements – but you don't have a free hand. The micro button on Rohde&Schwarz active probes solves this prob-

lem. It is conveniently situated on the probe tip, and you can assign it different functions, such as run/stop, autoset and adjust offset.

R&S®ProbeMeter: integrated voltmeter for precise DC measurements

One connection lets you see the oscilloscope waveform and gives you access to a highly accurate voltmeter that shows the DC value regardless of other instrument settings.

▶ For more information, see the product brochure: Probes and accessories for Rohde & Schwarz oscilloscopes (PD 3606.8866.12).



Practical design: micro button for convenient instrument control; diverse probe tips and ground cables are included as standard accessories

Probe type	Ideal for measuring	Recommended probes
Standard passive probe	Single-ended voltages, max. bandwidth of 500 MHz	R&S®RT-ZP05S comes as standard with the R&S®RTM3000
Active broadband probe	Singled-ended voltages, up to 8 GHz bandwidth	R&S®RT-ZS10E, R&S®RT-ZS10, R&S®RT-ZS20
Power integrity probe	Disturbances on power rails with high offsets, greater than 2 GHz bandwidth	R&S®RT-ZPR20
High voltage probe	High single-ended and differential voltages, up to 6 kV	R&S°RT-ZHD007, R&S°RT-ZHD15, R&S°RT-ZHD16, R&S°RT-ZHD60
Current probe	Currents from µAs to kAs	R&S°RT-ZC05B, R&S°RT-ZC10B, R&S°RT-ZC15B, R&S°RT-ZC20B, R&S°RT-ZC30
EMC near-field probe	EMI debugging up to 3 GHz	R&S®HZ-15

And there is so much more ...



- **I** Efficient reporting capabilities
- ı Localized GUI and online help
- I Fully upgradeable via software licenses
- I Web server functionality for instrument access
- I Extensive range of probes and accessories

Grows with your needs

The R&S®RTM3000 oscilloscopes flexibly adapt to needed project updates. You simply install the necessary software licenses, e.g. triggering and decoding of serial protocols or the history and segmented memory mode. The waveform and pattern generator and MSO capabilities 1) are built-in and just need to be activated. The bandwidth can be upgraded up to 1 GHz via keycode. All this makes retrofitting really easy.

1) The R&S®RTM-B1 MSO option additionally contains two logic probes with 16 digital channels.

Multilingual support: choose among thirteen languages

The R&S®RTM3000 oscilloscope's user interface and online help support thirteen languages (English, German, French, Spanish, Italian, Portuguese, Czech, Polish, Russian, simplified and traditional Chinese, Korean and Japanese). You can change the language in just a few seconds while the instrument is running.

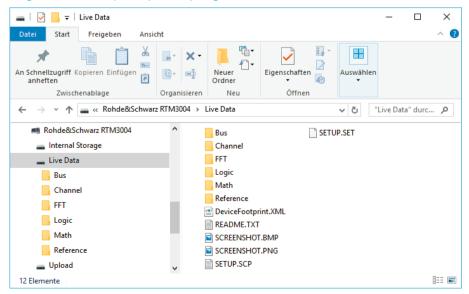
Protection of data

The secure erase function protects sensitive data. This function removes all user data and settings, including device setups and reference waveforms.

Connectivity

The R&S®RTM3000 can be directly connected to a PC via the built-in USB host and USB device ports. The USB host transfers screenshots and instrument settings to a USB stick. Media transfer protocol (MTP) implementation ensures seamless integration. The USB device port and the LAN interface enable remote control. The built-in web server functionality allows you to control the oscilloscope and display your screen content to an audience. Data and programming interfaces are included, e.g. for seamless MATLAB® integration.

With the USB MTP implementation, you can easily access live channel data and screenshots and integrate the oscilloscope into your computing environment



Oscilloscope portfolio









		10 000		
R&S®	RTH1000	RTC1000	RTB2000	RTM3000
Vertical				
Bandwidth	60/100/200/350/500 MHz ¹⁾	50/70/100/200/300 MHz ¹⁾	70/100/200/300 MHz ¹⁾	100/200/350/500 MHz/1 GHz ¹⁾
Number of channels	2 plus DMM/4	2	2/4	2/4
Resolution	10 bit	8 bit	10 bit	10 bit
V/div 1 MΩ	2 mV to 100 V	1 mV to 10 V	1 mV to 5 V	500 μV to 10 V
V/div 50 Ω	-			500 μV to 1 V
Horizontal				
Sampling rate per channel (in Gsample/s)	1.25 (4-channel model); 2.5 (2-channel model); 5 (all channels interleaved)	1; 2 (2 channels interleaved)	1.25; 2.5 (2 channels interleaved)	2.5; 5 (2 channels interleaved)
Max. memory (per channel/1 channel active)	125 ksample (4-channel model); 250 ksample (2-channel model); 500 ksample (50 Msample in segmented memory mode ²)	1 Msample; 2 Msample	10 Msample; 20 Msample (160 Msample in segmented memory mode ²⁾)	40 Msample; 80 Msample (400 Msample in segmented memory mode ²)
Segmented memory	option	_	option	option
Acquisition rate (in waveforms/s)	50 000	10 000	50 000 (300 000 in fast segmented memory mode ²⁾)	64000 (2000000 in fast segmented memory mode ²)
Trigger			mented memory mode 7	memory mode γ
Options	advanced, digital trigger	elementary (5 trigger types)	basic (7 trigger types)	basic (10 trigger types)
Орнопа	(14 trigger types) ²⁾	cicinentary (5 trigger types)	basic (7 trigger types)	basic (10 trigger types)
Mixed signal option				
No. of digital channels 1)	8	8	16	16
Sampling rate of digital channels (in Gsample/s)	1.25	1	1.25	two logic probes: 2.5 on each channel; one logic probe: 5 on each channel
Memory of digital channels	125 ksample	1 Msample	10 Msample	two logic probes: 40 Msample per channel; one logic probe: 80 Msample per channel
Analysis				
Cursor meas. types	4	13	4	4
Stand. meas. functions	33	31	32	32
Mask test	elementary (tolerance mask	elementary (tolerance mask	elementary (tolerance mask	elementary (tolerance mask around
	around the signal)	around the signal)	around the signal)	the signal)
Mathematics	elementary	elementary	basic (math on math)	basic (math on math)
Serial protocols triggering and decoding ¹⁾	I ² C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN, CAN-FD, SENT (7)	I ² C, SPI, UART/RS-232/ RS-422/RS-485, CAN, LIN (5)	I ² C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN (5)	I ² C, SPI, UART/RS-232/ RS-422/RS-485, CAN, LIN, I ² S, MIL-STD-1553, ARINC 429 (8)
Display functions	data logger	-	-	-
Applications 1), 2)	high-resolution frequency counter,	digital voltmeter (DVM), com-	digital voltmeter (DVM),	power, digital voltmeter (DVM), spectrum analysis
	advanced spectrum analysis, harmonics analysis	ponent tester, fast Fourier transform (FFT)	fast Fourier transform (FFT), frequency response analysis 3)	and spectrogram, frequency response analysis 3)
Compliance testing 1), 2)	advanced spectrum analysis,	ponent tester, fast Fourier		and spectrogram, frequency response analysis 3)
Compliance testing 1), 2) Display and operation	advanced spectrum analysis, harmonics analysis	ponent tester, fast Fourier transform (FFT)	frequency response analysis 3)	
	advanced spectrum analysis, harmonics analysis	ponent tester, fast Fourier transform (FFT)	frequency response analysis 3)	
Display and operation	advanced spectrum analysis, harmonics analysis	ponent tester, fast Fourier transform (FFT)	frequency response analysis ³⁾	10.1", color, 1280 × 800 pixel
Display and operation Size and resolution	advanced spectrum analysis, harmonics analysis - 7", color, 800 × 480 pixel optimized for touchscreen operation, parallel button	ponent tester, fast Fourier transform (FFT) - 6.5", color, 640 × 480 pixel optimized for fast button	frequency response analysis 3) - 10.1", color, 1280 × 800 pixel	10.1", color, 1280 × 800 pixel
Display and operation Size and resolution Operation	advanced spectrum analysis, harmonics analysis - 7", color, 800 × 480 pixel optimized for touchscreen operation, parallel button	ponent tester, fast Fourier transform (FFT) - 6.5", color, 640 × 480 pixel optimized for fast button	frequency response analysis 3) - 10.1", color, 1280 × 800 pixel	10.1", color, 1280 × 800 pixel
Display and operation Size and resolution Operation General data Dimensions in mm	advanced spectrum analysis, harmonics analysis - 7", color, 800 × 480 pixel optimized for touchscreen operation, parallel button operation	ponent tester, fast Fourier transform (FFT) 6.5", color, 640 × 480 pixel optimized for fast button operation	frequency response analysis ³⁾ - 10.1", color, 1280 × 800 pixel optimized for touchscreen opera	10.1", color, 1280 × 800 pixel tion, parallel button operation

¹⁾ Upgradeable.

²⁾ Requires an option.

³⁾ Available Q1 2019.

	HD 16 bit	HD 16 bit	HD 16 hir
Multi	Multi	Multi	Multi
RTA4000	RTE1000	RTO2000	RTP
200/350/500 MHz/1 GHz ¹⁾	200/350/500 MHz/1/1.5/2 GHz ¹⁾	600 MHz/1/2/3/4/6 GHz ¹⁾	4/6/8/13/16 GHz ¹⁾
4	2/4	2/4 (only 4 channels in 4 GHz and 6 GHz models)	4
10 bit	8 bit (up to 16 bit with HD mode)	8 bit (up to 16 bit with HD mode) ²⁾	8 bit (up to 16 bit with HD mode) ²⁾
500 μV to 10 V	500 μV to 10 V	1 mV to 10 V (500 μV to 10 V) ²⁾	
500 μV to 1 V	500 μV to 1 V	1 mV to 1 V (500 μV to 1 V) ²⁾	1 mV to 1 V
2.5; 5 (2 channels interleaved)	5	10; 20 (2 channels interleaved in 4 GHz and 6 GHz model)	20
100 Msample; 200 Msample (1 Gsample in segmented memory mode)	50 Msample/200 Msample	standard: 50 Msample/200 Msample; max. upgrade: 1 Gsample/2 Gsample	standard: 50 Msample/200 Msample; max. upgrade: 1 Gsample/2 Gsample
standard	standard	standard	standard
64000 (2000000 in fast segmented memory mode)	1 000 000 (1 600 000 in ultra-segmented memory mode)	1000000 (2500000 in ultra-segmented memory mode)	950000 (3200000 in ultra-segmented memory mode)
basic (10 trigger types)	advanced, digital trigger (13 trigger types)	advanced (includes zone trigger), digital trigger (14 trigger types) ²⁾	advanced, digital trigger (14 trigger types) with realtime deembedding ²⁾ , zone trigger ²⁾
10	10	10	10
16	16	16	16
two logic probes: 2.5 on each channel; one logic probe: 5 on each channel	5	5	5
two logic probes: 100 Msample per channel; one logic probe: 200 Msample per channel	100 Msample	200 Msample	200 Msample
			_
4	3	3	3
32	47	47	47
elementary (tolerance mask around the signal)	advanced (user-configurable, hardware based)	advanced (user-configurable, hardware based)	advanced (user-configurable, hardware based)
basic (math on math)	advanced (formula editor)	advanced (formula editor)	advanced (formula editor)
I ² C, SPI, UART/RS-232/RS-422/ RS-485, CAN, LIN, I ² S, MIL-STD-1553, ARINC429 (8)	I²C, SPI, UART/RS-232/RS-422/RS-485, CAN, LIN, I²S, MIL-STD-1553, ARINC 429, FlexRay™, CAN-FD, USB 2.0/HSIC, Ethernet, Manchester, NRZ, SENT, SpaceWire, CXPI, USB Power Delivery, automotive Ethernet 100BASE-T1 (19)	I ² C, SPI, UART/RS-232/RS-422/RS-485, CAN, LIN, I ² S, MIL-STD-1553, ARINC 429, FlexRay™, CAN-FD, MIPI RFFE, USB 2.0/HSIC, MDIO, 8b10b, Ethernet, Manchester, NRZ, SENT, MIPI D-PHY, SpaceWire, MIPI M-PHY/UniPro, CXPI, USB 3.1 Gen1, USB-SSIC, PCle 1.1/2.0, USB Power Delivery, automotive Ethernet 100BASE-T1 (27)	I ² C, SPI, UART/RS-232/RS-422/RS-485, CAN, LIN, CAN-FD, MIPI RFFE, USB 2.0/ HSIC, MDIO, 8b10b, Ethernet, Manchester, NRZ, MIPI D-PHY, MIPI M-PHY/UniPro, USB 3.1 Gen1, USB-SSIC, PCIe 1.1/2.0, USB Power Delivery, automotive Ethernet 100BASE-T1 (20)
-	histogram, trend, track ²⁾	histogram, trend, track ²⁾	histogram, trend, track
power, digital voltmeter (DVM), spectrum analysis and spectrogram, frequency response analysis ³⁾	power, 16-bit high definition mode (standard), advanced spectrum analysis and spectrogram	power, 16-bit high definition mode, advanced spectrum analysis and spectrogram, jitter, clock data recovery, I/Q data, RF analysis various options available (see PD 3607.2684.22)	16-bit high definition mode, advanced spectrum analysis and spectrogram, jitter, RF analysis, realtime deembedding various options available (see PD 5215.4152.22)
10.1", color, 1280 × 800 pixel	10.4", color, 1024 × 768 pixel	12.1", color, 1280 x 800 pixel	12.1", color, 1280 × 800 pixel
optimized for touchscreen operation, para	allel button operation		

390 × 220 × 152	427 × 249 × 204	427 × 249 × 204	441 × 285 × 316
3.3	8.6	9.6	18
_	_	-	-

Base unit

Vertical system

Input channels	R&S®RTM3002	2 channels	
	R&S®RTM3004	4 channels	
Input impedance		$50 \Omega \pm 1.5 \%$ (meas.)	
		1 MΩ ± 1 % 14 pF ± 1 pF (meas.)	
Analog bandwidth (-3 dB)	at 50 Ω input impedance		
	R&S®RTM3002 and R&S®RTM3004	> 100 MHz	
	R&S®RTM3002 with -B222 option and	> 200 MHz	
	R&S®RTM3004 with -B242 option		
	R&S®RTM3002 with -B223 option and	> 350 MHz	
	R&S®RTM3004 with -B243 option		
	R&S®RTM3002 with -B225 option and	> 500 MHz	
	R&S®RTM3004 with -B245 option		
	R&S®RTM3002 with -B2210 option and	> 1 GHz	
	R&S®RTM3004 with -B2410 option		
	at 1 MΩ input impedance		
	R&S®RTM3002 and R&S®RTM3004	> 100 MHz (meas.)	
	R&S®RTM3002 with -B222 option and	> 200 MHz (meas.)	
	R&S®RTM3004 with -B242 option		
	R&S®RTM3002 with -B223 option and	> 350 MHz (meas.)	
	R&S®RTM3004 with -B243 option	,	
	R&S®RTM3002 with -B225 option and	> 500 MHz (meas.)	
	R&S®RTM3004 with -B245 option		
	R&S®RTM3002 with -B2210 option and	> 500 MHz (meas.)	
	R&S®RTM3004 with -B2410 option		
_ower frequency limit (-3 dB)	at AC coupling	< 5 Hz (meas.)	
Analog bandwidth limits	at 50 Ω input impedance		
S .	R&S®RTM3002 and R&S®RTM3004	20 MHz	
	R&S®RTM3002 with -B222 option and	20 MHz, 100 MHz	
	R&S®RTM3004 with -B242 option	,	
	R&S®RTM3002 with -B223 option and	20 MHz, 100 MHz, 200 MHz	
	R&S®RTM3004 with -B243 option	,,,	
	R&S®RTM3002 with -B225 option and	20 MHz, 100 MHz, 200 MHz, 350 MHz	
	R&S®RTM3004 with -B245 option	20 1111 12, 100 1111 12, 200 1111 12, 200 1111 12	
	R&S®RTM3002 with -B2210 option and	20 MHz, 100 MHz, 200 MHz, 350 MHz,	
	R&S®RTM3004 with -B2410 option	500 MHz	
	at 1 M Ω input impedance	000 III IZ	
	R&S®RTM3002 and R&S®RTM3004	20 MHz	
	R&S®RTM3002 with -B222 option and	20 MHz, 100 MHz	
	R&S®RTM3004 with -B242 option	20 WH 12, 100 WH 12	
	R&S®RTM3002 with -B223 option and	20 MHz, 100 MHz, 200 MHz	
	R&S®RTM3004 with -B243 option	20 WH 12, 100 WH 12, 200 WH 12	
	R&S®RTM3002 with -B225 option,	20 MHz, 100 MHz, 200 MHz, 350 MHz	
	R&S®RTM3004 with -B245 option,	20 WH 12, 100 WH 12, 200 WH 12, 330 WH 12	
	R&S®RTM3002 with -B2210 option and		
	R&S®RTM3004 with -B2410 option		
Rise time (calculated)	R&S®RTM3002 and R&S®RTM3004	< 3.5 ns	
rise time (calculated)		< 1.75 ns	
	R&S [®] RTM3002 with -B222 option and R&S [®] RTM3004 with -B242 option	< 1.73 118	
		< 1 ns	
	R&S®RTM3002 with -B223 option and	< 1 ns	
	R&S®RTM3004 with -B243 option	4 700 pg	
	R&S®RTM3002 with -B225 option and	< 700 ps	
	R&S®RTM3004 with -B245 option	050	
	R&S®RTM3002 with -B2210 option and	< 350 ps	
	R&S®RTM3004 with -B2410 option		

Vertical resolution		10 bit, up to 16 bit with high resolution		
DO		decimation		
DC gain accuracy	offset and position = 0			
	maximum operating temperature change of ±5 °C after self-alignment			
	input sensitivity > 5 mV/div	±1.5 %		
	input sensitivity ≤ 5 mV/div to	±2 %		
	≥ 1 mV/div			
	input sensitivity < 1 mV/div	±3 %		
nput coupling		DC, AC, GND		
nput sensitivity	at 50 Ω	0.5 mV/div to 1 V/div		
	at 1 MΩ	0.5 mV/div to 10 V/div		
Maximum input voltage	at 50 Ω	5 V (RMS), max. 30 V (V _p)		
	at 1 MΩ	300 V (RMS), 400 V (V _p),		
		derates at 20 dB/decade to 5 V (RMS)		
		above 250 kHz		
Position range		±5 div		
Offset range at 50 Ω	input sensitivity			
	≥ 112 mV/div to 1 V/div	±(30 V − 5 div × input sensitivity)		
	≥ 33.8 mV/div to 111 mV/div	±(10 V − 5 div x input sensitivity)		
	0.5 mV/div to 33.6 mV/div	±(2 V − 5 div × input sensitivity)		
Offset range at 1 MΩ	input sensitivity			
	≥ 515 mV/div to 10 V/div	±(250 V − 5 div × input sensitivity)		
	≥ 50.5 mV/div to 510 mV/div	±(25 V − 5 div × input sensitivity)		
	0.5 mV/div to 50 mV/div	$\pm (2 \text{ V} - 5 \text{ div} \times \text{input sensitivity})$		
Offset accuracy		±(0.5 % × offset +		
•		0.1 div x input sensitivity + 0.5 mV)		
DC measurement accuracy	after adequate suppression of	±(DC gain accuracy x reading - net		
•	measurement noise by using either high-	offset + offset accuracy)		
	resolution sampling mode or waveform			
	averaging, or a combination of both			
Channel-to-channel isolation	input frequency < analog bandwidth	> 50 dB		
(each channel at same input sensitivity)				

Horizontal system

Timebase range		selectable between
-		0.5 ns/div and 500 s/div
Channel deskew		±500 ns
Trigger offset range	minimum	memory depth
		actual sampling rate
	maximum	2 ³³
		actual sampling rate
Modes		normal, roll
Channel-to-channel skew		< 200 ps (meas.)
Timebase accuracy	after delivery/calibration, at +23 °C	±2.5 ppm
	during calibration interval	±3.5 ppm

Acquisition system

Maximum realtime sampling rate	normal mode	2.5 Gsample/s
	interleaved mode,	5 Gsample/s
	if following channels are not used	
	simultaneously:	
	 channel 1 and channel 2 	
	 channel 3 and channel 4 	
	logic channels	
Memory depth per channel	normal mode	40 Msample per channel
	interleaved mode,	80 Msample per channel
	if following channels are not used	
	simultaneously:	
	channel 1 and channel 2	
	channel 3 and channel 4	
	logic channels	
Acquisition modes	sample	first sample in decimation interval
	peak detect	largest and smallest sample in decimation interval
	high resolution	average value of all samples in decimation interval
	envelope	envelope of acquired waveforms
	average	average over a series of acquired waveforms
	envelope + peak detect	envelope of acquired waveforms with active peak detect
	envelope + high resolution	envelope of acquired waveforms with active high resolution
	average + high resolution	average over a series of acquired high
		resolution waveforms
Number of averaged waveforms		2 to 100 000
Waveform acquisition rate	dot display, single channel, auto record length	up to 64 000 waveforms/s

Trigger system

Trigger level	range	±5 div from center of screen
Trigger modes		auto, normal, single,
		n single with R&S®RTM-K15 option
Hold-off range	time	inactive or 51.2 ns to 13.7 s
Trigger types		edge, width, video, pattern, runt, rise time,
		fall time, serial bus, line, timeout
Edge trigger A	trigger events	rising edge, falling edge, both edges
	R&S®RTM3002	channel 1, channel 2, logic channels from
		D15 to D0 (with R&S®RTM-B1 option),
		external trigger input
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
		(with R&S®RTM-B1 option), external
		trigger input
	trigger coupling	DC,
		AC (attenuates < 10 Hz (meas.)),
		LF reject (attenuates < 10 kHz (meas.))
	trigger filter	HF reject (attenuates > 100 kHz (meas.)),
		noise reject (attenuates > 100 MHz
		(meas.))
	selectable trigger hysteresis	automatic, small, medium, large

Trigger A sensitivity hysteresis mode	with DC, AC, LF reject, noise reject	
automatic	1 GHz, 500 MHz, 350 MHz	$2.2 mV_{pp}$
	, , , , , , , , , , , , , , , , , , , ,	$> \frac{2.2 mv_{pp}}{input sensitivity} + 1 div (nom.)$
		(input sensitivity: [mV/div])
	200 MHz, 100 MHz	· · · · · · · · · · · · · · · · · · ·
	200 WII 12, 100 WII 12	$> \frac{1.5 mV_{pp}}{input sensitivity} + 0.8 div (nom.)$
		input sensitivity
		(input sensitivity: [mV/div])
	20 MHz	$> \frac{0.6 mV_{pp}}{1.00 mV_{pp}} + 0.4 div (nom.)$
		input sensitivity + 0.4 atv (nom.)
		(input sensitivity: [mV/div])
	with HF reject	
	all input sensitivities	1 div (meas.)
Edge trigger A and B	trigger events	rising edge, falling edge, both edges
	sources for A trigger	
	R&S [®] RTM3002	channel 1, channel 2, logic channels from
		D15 to D0 (with R&S®RTM-B1 option)
	R&S [®] RTM3004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
		(with R&S®RTM-B1 option)
	trigger coupling of A trigger	DC
	sources for B trigger	
	R&S®RTM3002	channel 1, channel 2, logic channels from
		D15 to D0 (with R&S®RTM-B1 option)
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
		(with R&S®RTM-B1 option)
	trigger coupling of B trigger	DC
	selectable trigger hysteresis for A and B	small, medium, large
	trigger	, a 3
	trigger B mode	after time or after events
	trigger B minimum time	3.2 ns
	trigger B maximum time	100 s
	trigger B events	1 to 65535
Width trigger	trigger events	pulse width is smaller, greater, equal,
Widan anggor	ingger evente	unequal, inside interval, outside interval
	minimum pulse width	3.2 ns
	maximum pulse width	6.8 s
	polarity	positive, negative
	sources	
	R&S®RTM3002	channel 1, channel 2, logic channels from
	TAG TTWOODE	D15 to D0 (with R&S®RTM-B1 option)
	R&S®RTM3004	channel 1, channel 2, channel 3,
	Tide Titillioo	channel 4, logic channels from D15 to D0
		(with R&S®RTM-B1 option)
	selectable trigger hysteresis	small, medium, large
Timeout trigger	trigger events	greater than timeout
	minimum timeout	3.2 ns
	maximum timeout	6.8 s
	polarity	stays high, stays low, stays high or low
	sources	Jacky o ringri, orayo low, orayo ringri or low
	R&S®RTM3002	channel 1, channel 2, logic channels from
	NAO MINIOUZ	D15 to D0 (with R&S®RTM-B1 option)
	R&S®RTM3004	channel 1, channel 2, channel 3,
	AGO ICTIVIOUT	channel 4, logic channels from D15 to D0
		(with R&S®RTM-B1 option)
	selectable trigger hysteresis	small, medium, large
Video trigger	trigger events	selectable line, all lines, even frame,
video trigger	ingger events	odd frame, all frames
	supported standards	PAL, NTSC, SECAM, PAL-M, SDTV 576i,
	συρροπού σταπιματώς	HDTV 720p, HDTV 1080i, HDTV 1080p
	sources	יוטוי ועוט ויעווער ויעווי וער ויער ויער ויער ויער
	R&S®RTM3002	channel 1, channel 2, ext. trigger input
	R&S®RTM3004	channel 1, channel 2, channel 3,
	R&S RTW5004	
	sync pulse polarity	channel 4, ext. trigger input positive, negative

Pattern trigger	trigger events	logic condition between active channels	
- -	sources		
	R&S®RTM3002	channel 1, channel 2, logic channels from D15 to D0 (with R&S®RTM-B1 option)	
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0	
		(with R&S®RTM-B1 option)	
	state of channels	high, low, don't care	
	logic between channels	and/or	
	condition	true, false	
	duration condition	smaller, greater, equal, unequal, inside interval, outside interval, timeout	
	minimum duration time	3.2 ns	
	maximum duration time	6.8 s	
Runt trigger		triggers on pulse of positive, negative or either polarity that crosses one threshold but fails to cross a second threshold before crossing the first one again	
Rise time, fall time	trigger events	time between the crossing of two	
Nise time, rail time	tilgger evertes	selectable levels is smaller, greater, equal, unequal, inside interval, outside interval	
	minimum rise time	3.2 ns	
	maximum rise time	6.8 s	
	polarity	rising edge, falling edge, both edges	
	sources		
	R&S®RTM3002	channel 1, channel 2	
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4	
Serial bus trigger	supported standards	Official of 1	
Conai suo inggo.	R&S®RTM-K1 option	I ² C,	
	The Transfer of the Transfer o	SSPI (two-wire, MOSI/MISO), SPI (three-wire, MOSI/MISO)	
	R&S®RTM-K2 option	UART/RS-232/RS-422/RS-485 (RX/TX)	
	R&S®RTM-K3 option	CAN/LIN (
	R&S®RTM-K5 option	audio (I ² S, LJ, RJ, TDM)	
	R&S®RTM-K6 option	MIL-STD-1553	
	R&S®RTM-K7 option	ARINC 429	
External trigger input	input impedance	$1 M\Omega \pm 1 \%$ with 14 pF ± 2 pF (meas.)	
	maximum input voltage at 1 MΩ	300 V (RMS), 400 V (V _p), derates at 20 dB/decade to 5 V (RMS)	
	tria a a u la cal	above 250 kHz	
	trigger level	±5 V	
	sensitivity	> 300 mV (V _{pp})	
	coupling	DC, AC, LF reject	
Trigger output	functionality	A pulse is generated for every acquisition trigger event.	
	output voltage		
	at high impedance	0 V to 4.8 V	
	at 50 Ω	0 V to 2.4 V	
	pulse polarity	high active	

Waveform measurements

Automatic measurements	measurements on channels, math waveforms, reference waveforms	burst width, count positive pulses, count negative pulses, count falling edges, count rising edges, mean value, RMS cycle, RMS, mean cycle, peak peak, peak+, peak-, frequency, period, amplitude, top level, base level, positive overshoot, negative overshoot, pulse width+, pulse width-, duty cycle+, duty cycle-, rise time, fall time, delay, phase, crest factor, slew rate+, slew rate-, o.std. deviation, o.std. deviation cycle
	reference levels	lower, middle and upper level in percentage
	statistics	maximum, minimum, mean, standard deviation and measurement count for each automatic measurement
	number of active measurements	8
Cursor measurements	type	vertical, horizontal, vertical and horizontal, V-marker
	functions	x and y tracking, coupling of cursors, set to trace, set to screen
Quick measurements	function	fast overview of measurements from one channel, some measurements displayed with result lines in diagram
	sources	
	R&S®RTM3002	channel 1, channel 2
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4
	measurements displayed in diagram	mean, max. peak, min. peak, rise time, fall time
	numerically displayed measurements	RMS cycle, peak-to-peak voltage, period, frequency

Digital voltmeter

Accuracy		related to channel settings of voltmeter
		source
Measurements		DC, AC+DC RMS, AC RMS
Sources	R&S®RTM3002	channel 1, channel 2
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4
Number of measurements		up to 4
Resolution		up to 3 digits
Bandwidth		1 MHz

Counter

Measurements		frequency, period
Sources	R&S®RTM3002	channel 1, channel 2, trigger signal
		source
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4, trigger signal source
Number of measurements		2
Resolution		6 digits
Frequency range		0. 05 Hz to bandwidth of oscilloscope
		(limited by bandwidth of trigger filter)

Mask testing

Sources	R&S®RTM3002	channel 1, channel 2
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4
Mask definition		acquired waveform with user-defined
		tolerance, can be stored and restored
Result statistics		completed acquisitions, passed and failed
		acquisitions (absolute and in percent),
		test duration
Actions on mask violation		sound, acquisition stop, screenshot, save
		waveform, pulse out (AUX OUT
		connector)
Captured segments	with R&S®RTM-K15 option	all segments, failed segments

Waveform maths

Number of math equations		up to 5
Functions		addition, subtraction, multiplication,
		division, square, square root, absolute
		value, reciprocal, inverse, log10, ln,
		derivation, integration, low pass, high pass
Sources	R&S®RTM3002	channel 1, channel 2,
		math waveforms 1 to 4
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4, math waveforms 1 to 4

Fast Fourier transformation (FFT)

Sources	R&S®RTM3002	channel 1, channel 2, math waveforms, references
	R&S®RTM3004	channel 1, channel 2, channel 3,
	1300 1333000	channel 4, math waveforms, references
Setup parameters		start frequency, stop frequency, center frequency, frequency span, vertical scale, vertical position, resolution bandwidth, gate (time range and position)
Windows		Hanning, Hamming, Blackman, rectangular, flat top
Waveform arithmetic		none, min. hold, max. hold, average (selectable from 2 to 1024)
Scaling		dBm, dBV, dBμV, V (RMS)

Search function

Functions	search types	edge, width, peak, rise/fall time, runt,
		data2clock, pattern, window, protocol
		(available with R&S®RTM-K3,
		R&S®RTM-K6 and R&S®RTM-K7 options)
	configuration	manual level setting on screen, level with
		selectable hysteresis
	display of search events	up to 10 000 events in diagram and in
		result table
	markers on search events	up to 32 markers
	navigation in search events (stop mode)	knob (if result table is active)
Sources	R&S®RTM3002	channel 1, channel 2,
		math waveforms from 1 to 5,
		D15 to D0 (with R&S®RTM-B1 option)
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4, math waveforms from 1 to 5,
		D15 to D0 (with R&S®RTM-B1 option)

Display characteristics

Diagram types	manually changeable vertical window size	Yt, XY, zoom, FFT, spectrogram (with R&S®RTM-K18 option)
XY mode		parallel display of XY diagram and Yt diagrams of input signals for X, Y
Zoom		horizontal and vertical zoom, split screen with overview signal and zoomed signal
Interpolation		sin(x)/x, linear, sample & hold
FFT mode		split screen with Yt diagrams and
		dedicated frequency diagram, spectrogram (with R&S®RTM-K18 option)
Waveform display		lines, dots only
Persistence		50 ms to 12.8 s; infinite
Special display mode		inverse brightness, waveform color modes for analog channels (temperature, fire, rainbow)
Diagram grid		lines, reticle, none, with annotation, track grid
Reference signals		up to 4 reference signals

Protocol and logic

Bus decode	number of bus signals	4 ¹
	bus types	 parallel, parallel clocked SSPI, SPI, I²C (R&S®RTM-K1 option) UART/RS-232/RS-422/RS-485 (R&S®RTM-K2 option) CAN, LIN (R&S®RTM-K3 option) I²S, LJ, RJ, TDM (R&S®RTM-K5 option) MIL-STD-1553 (R&S®RTM-K6 option) ARINC 429 (R&S®RTM-K7 option)
	display types	decoded bus, logical signal, frame table (depends on decoded bus)
	position and size	size and position on screen selectable
	data format of decoded bus	hex, decimal, binary, octal, ASCII

¹ If a bidirectional bus is used (e.g. UART RX/TX or SPI MOSI/MISO), two bus decoders are occupied.

Miscellaneous

Save/recall	device settings	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
	reference waveforms	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
	waveforms	save on USB memory stick or download and save on a PC via web interface or USB-MTP, available file formats: BIN, CSV, TXT float (MSB/LSB first)
	screenshots	save on USB memory stick or download and save on a PC via web interface or USB-MTP, available file formats: BMP, PNG
	device settings	save and recall on internal file system or USB memory stick or on a PC via web interface or USB-MTP
Camera key		configurable camera key, actions on press: save screenshot one-touch
	save screenshot	one-touch off
	one-touch	one or more from the list:
Instrument security		secure erasure of internal file system and all settings
Menu languages		available menu languages: English German French Spanish Italian Portuguese Czech Polish Russian Simplified Chinese Traditional Chinese Korean Japanese
Help		online help, available languages: • English
Undo/redo		deep undo/redo function

Input and outputs

Front			
Channel inputs		BNC, for details see Vertical system	
	probe interface	auto detection of passive probes,	
	·	Rohde & Schwarz active probe interface	
External trigger input		BNC, for details see Trigger system	
	probe interface	auto detection of passive probes	
Waveform generator	i	BNC, for details see R&S®RTM-B6,	
(requires R&S®RTM-B6 option)		waveform generator,	
		demo lug and GND lug	
Probe compensation output	signal shape	rectangle	
	frequency	1 kHz	
	voltage	$V_{low} = 0 \text{ V}, V_{high} = 1.5 \text{ V to } 3.3 \text{ V (meas.)}$	
Pattern source	P3 to P0	4 lugs, for details see R&S®RTM-B6,	
(requires R&S®RTM-B6 option)		4-bit pattern generator	
,	frequency	1 mHz to 25 MHz	
	voltage	$V_{low} = 0 \text{ V}, V_{high} = 1.5 \text{ V to } 3.3 \text{ V (meas.)}$	
Ground lug		connected to ground	
USB host interface		1 port, type A plug, version 2.0,	
		flash drives only	
Rear			
Ethernet interface		1 port, 1 Gbit	
AUX OUT (BNC)	trigger out,	for details see Trigger system	
	reference frequency	10 MHz ±3.5 ppm (meas.)	
	mask violation	pulse	
USB device interface		1 port, type B plug, version 2.0	
Fixation loop		for securing the instrument with a cable	
Security slot		for standard Kensington style lock	
Right side			
Digital channel inputs	D15 to D8, D7 to D0	requires R&S®RTM-B1 option	

General data

Display		
Type		10.1" WXGA display with capacitive touch
Resolution		1280 × 800 pixel (WXGA)
Temperature		
Temperature loading	operating temperature range	0 °C to +50 °C
	storage temperature range	-40 °C to +70 °C
Climatic loading		+25 °C/+40 °C at 85 % rel. humidity cyclic,
ŭ		in line with IEC 60068-2-30
Altitude		
Operating		up to 3000 m above sea level
Nonoperating		up to 4600 m above sea level
Mechanical resistance		
Vibration	sinusoidal	5 Hz to 150 Hz, max. 1.8 g at 55 Hz;
		0.5 g from 55 Hz to 150 Hz,
		in line with EN 60068-2-6
		MIL-PRF-28800F, 4.5.5.3.2 sinusoidal
		vibration, class 3 and 4
	random	10 Hz to 300 Hz,
		acceleration 1.2 g (RMS),
		in line with EN 60068-2-64,
		MIL-PRF-28800F, 4.5.5.3.1 random
		vibration, class 3 and 4
Shock		40 g shock spectrum,
		in line with MIL-STD-810E, method
		no. 516.4, procedure I,
		MIL-PRF-28800F, 4.5.5.4.1 functional
		shock, 30 g, 11 ms, halfsine
EMC		, ee., e.e g,
RF emission		in line with CISPR 11/EN 55011 group 1
		class A (for a shielded test setup);
		the instrument complies with the emission
		requirements stipulated by EN 55011,
		EN 61326-1 and EN 61326-2-1 class A,
		making the instrument suitable for use in
		industrial environments
Immunity		in line with IEC/EN 61326-1 table 2,
minianty		immunity test requirements for industrial
		environments ²
Certifications		VDE, _C CSA _{US} , KC
Calibration interval		1 year
Power supply		1 your
AC supply		100 V to 240 V at 50 Hz to 60 Hz
AC supply		
Dower concumption		1.6 A to 0.7 A
Power consumption		max. 160 W
Safety		in line with
		• IEC 61010-1, IEC 61010-2-030
		• EN 61010-1, EN 61010-2-030
		• CAN/CSA-C22.2 No. 61010-1
		• CAN/CSA-C22.2 No. 61010-2-030
Machanical data		• UL 61010-1, UL 61010-2-030
Mechanical data	W×H×D	200 mm v 220 mm v 152 mm
Dimensions	W X II X D	390 mm × 220 mm × 152 mm
M/a: alat	with and antique ()	(15.35 in × 8.66 in × 5.98 in)
Weight	without options (nom.)	3.3 kg (7.275 lb)
Audible noise	maximum sound pressure level at a	28.3 dB(A)
	distance of 1.0 m	

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² Test criterion is displayed noise level within ±1 div for input sensitivity of 5 mV/div.

Options

R&S®RTM-B1

Vertical system			
Input channels		16 logic channels (from D15 to D0)	
Arrangement of input channels		arranged in two logic probes with 8 channels each, assignment of the log probes to the channels D15 to D8 and to D0	
Input impedance		100 kΩ ± 2 % ~4 pF (meas.) at probe tips	
Maximum input frequency	signal with minimum input voltage swing and hysteresis setting: normal	400 MHz (meas.)	
Maximum input voltage		±40 V (V _p)	
Minimum input voltage swing		500 mV (V _{pp}) (meas.)	
Threshold groups		from D15 to D12, D11 to D8, D7 to D4 and D3 to D0	
Threshold level	user range	±8 V in 25 mV steps	
	predefined	CMOS 2.5 V, TTL 1.4 V, ECL -1.3 V	
Threshold accuracy		±(100 mV + 3 % of threshold setting)	
Comparator hysteresis		small, medium, large	
Horizontal system			
Channel deskew	range for each channel	±500 ns	
Channel-to-channel skew		< 200 ps (meas.) for same vertical settir on the channels	
Acquisition system	<u>'</u>	<u>'</u>	
Sampling rate	two logic probes	2.5 Gsample/s on each channel	
-	one logic probe	5 Gsample/s on each channel	
Memory depth	two logic probes	40 Msample for every channel	
• •	one logic probe	80 Msample for every channel	
Trigger system		see chapter Trigger system of the base unit	
Waveform measurements			
Measurement sources		all channels from D15 to D0	
Automatic measurements		positive pulse width, negative pulse width, period, frequency, burst width, delay, phase, positive duty cycle, negative duty cycle, positive pulse count, negative pulse count, rising edge count, falling edge count	
Additional cursor function		display of hex value at the cursor position	
Display characteristics			
Channel activity display		independent of the oscilloscope acquisition, the state (stays low, stays high or toggles) of the channels from D15 to D0 is displayed	

R&S®RTM-B6

Waveform generator					
Resolution		14 bit			
Sample rate		250 Msample/s			
Amplitude	level				
p.maao	high Z	20 mV to 10 V (V _{pp})			
	50 Ω	10 mV to 5 V (V _{pp})			
	accuracy	3 %			
DC offset	level	3 70			
DC onset	high Z	±5 V			
	50 Ω	± 3 V ± 2.5 V			
		3 % or ± 5 mV whatever is greater			
Sine	accuracy	0.1 Hz to 25 MHz			
Sine	frequency				
	SFDR	> 40 dBc (meas.)			
	THD	> 40 dBc (meas.)			
Rectangle	frequency	0.1 Hz to 10 MHz			
Pulse	frequency	0.1 Hz to 10 MHz			
	edge time	adjustable			
	duty cycle	1 % to 99 %			
Ramp, triangle, sinc, exponential	frequency	0.1 Hz to 1 MHz			
Arbitrary	sample rate	max. 10 Msample/s			
	memory depth	32k point			
Noise	bandwidth	max. 25 MHz			
	level	0 to 100 % of signal amplitude			
Modulation	AM	·			
	function	sine, rectangle, triangle, ramp			
	frequency	0.1 Hz to 1 MHz			
	depth	0 to 100 %			
	FM				
	function	sine, rectangle, triangle, ramp			
	frequency	0.1 Hz to 1 MHz			
	deviation	depends on modulation frequency			
	ASK	acpends on modulation nequency			
	function	sine, rectangle, triangle, ramp			
		0.1 Hz to 1 MHz			
	frequency				
	ASK depth	0 to 100 %			
	FSK				
	function	sine, rectangle, triangle, ramp			
	frequency	0.1 Hz to 1 MHz			
	FSK rate	0.1 Hz to carrier frequency/2			
Sweep	start frequency	1 Hz to 25 MHz			
	stop frequency	1 Hz to 25 MHz			
	sweep time	1 ms to 10 s			
	sweep type	linear, logarithmic, triangle			
Burst	number of cycle	1 to 1024			
	idle time	28 ns to 17 s			
	start phase	0° to 360°			
	trigger	continuous, manually			
4-bit pattern generator					
Functions		probe adjust/square wave, bus signal			
		source 4-bit counter, programmable 4-bi			
		pattern			
Bus signal source		SPI, I ² C, UART, CAN, LIN			
	bandwidth	9600 bit/s to 1 Mbit/s			
4-bit counter	frequency	25 mHz to 50 MHz			
Programmable pattern	sample rate	20 ns to 1 s, up/down			
Togrammable pattern					
	square wave frequency	1 mHz to 500 kHz			
	memory depth pattern idle time	8096 bit per channel			
		50 ns to 1 s $V_{low} = 0 \text{ V}, V_{high} = 1.5 \text{ V}$ to 3.3 V (meas.			

I ² C triggering and decoding					
Bus configuration		sources for SCL and SDA			
	R&S®RTM3002	channel 1, channel 2, logic channels from D15 to D0 (requires R&S®RTM-B1 option)			
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTM-B1 option)			
	bit rate	up to 10 Mbps			
	size of address	7 bit or 10 bit			
	size of data	8 bit			
	label list	associate frame identifier with symbolic ID			
Trigger	trigger events	start, stop, restart, missing acknowledge, address (7 bit or 10 bit), data, address and data			
	offset for trigger on data	0 data byte to 4095 data byte			
	data pattern width	up to 3 sequential data byte			
Decode	displayed signals	bus signal, logic signal or both			
	color coding of bus signal	address, data, start, stop, ACK, NACK, error			
	displayed format of address	hex, symbolic ID (label list)			
	displayed format of data	ASCII, binary, decimal or hex			
SPI triggering and decoding					
Bus configuration	sources for CS, CLK, MOSI and MISC)			
	R&S®RTM3002	channel 1, channel 2, logic channels from D15 to D0 (requires R&S®RTM-B1 option)			
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTM-B1 option)			
	bit rate	up to 25 Mbps			
	chip select (CS)	active low, active high or missing (SSPI)			
	clock (CLK) slope	rise or fall			
	data symbol size	1 bit to 32 bit			
	idle time for SSPI	12.8 ns to 26.8 ms			
Trigger	trigger events	start of frame, end of frame, bit number, data pattern			
	selectable bit number	0 to 4095			
	offset for trigger on data pattern	0 to 4095 bit			
	data pattern size	1 bit to 32 bit			
Decode	displayed signals	bus signal, logic signal or both			
	color coding of bus signal	data, start, stop, error			
	displayed format of data	ASCII, binary, decimal or hex			
	data decoding	MSB or LSB first			

Bus configuration	source for RX and TX	and decoding source for RX and TX		
J	R&S [®] RTM3002	channel 1, channel 2, logic channels from D15 to D0 (requires R&S®RTM-B1 option)		
	R&S®RTM3004	channel 1, channel 2, channel 3,		
		channel 4, logic channels from D15 to D0		
		(with R&S®RTM-B1 option)		
	bit rate	300 bps to 1 Mbps or		
		user-selectable up to 6 Mbps		
	end of frame	timeout		
	signal polarity	idle low, idle high		
	data symbol size	5 bit to 9 bit		
	parity	none, even or odd		
	stop bits	1, 1.5 or 2		
	Idle time	up to 26.8 ms		
Trigger	trigger events	start bit, start of frame, symbol number, any symbol, pattern of symbols, parity error, stop bit error, break		
	offset for trigger on data symbol	0 to 4095 symbols		
	data symbol pattern width	1 to floor (32/symbol size) symbols		
Decode	displayed signals	bus signal, logic signal or both		
	color coding of bus signal	data, start, stop, error, parity		
	displayed format of data	ASCII, binary, decimal or hex		

CAN triggering and decoding		
Bus configuration	signal type	CAN_H, CAN_L
	bit rate	10/20/33.3/50/83.3/100/125/250/500/
		1000 kbps or user-selectable in range
		from 100 bps to 2 Mbps
	sampling point	10 % to 90 % within bit period
	label list	associate frame identifier with symbolic ID
Frigger	trigger events	start of frame, frame type, identifier,
		identifier + data, error condition (any
		combination of CRC error, bit stuffing
		error, form error and ACK error)
	identifier setup	frame type (data, remote or both),
	,	identifier type (11 bit or 29 bit);
		condition =, ≠, >, <; identifier selectable
		from label list
	data setup	data pattern up to 8 byte (hex or binary);
	adia ostap	condition =, \neq , >, <
Decode	displayed signals	bus signal, logic signal or both
500000	color coding of bus signal	start of frame, identifier, DLC, data
	color county of bus signal	payload, CRC, ACK, end of frame, error
		frame, overload frame, CRC error, bit
		stuffing error, ACK error
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list
	Hairie table	errors highlighted in red; frame navigation
2 b		data export as CSV file
Search	search events	frame, error, identifier, identifier + data,
		identifier + error
	frame event setup	start of frame, end of frame, overload
		frame, error frame, data ID 11 bit, data ID
		29 bit, remote ID 11 bit, remote ID 29 bit
	error event setup	any combination of CRC error, bit stuffing
		error, form error and ACK error
	identifier setup	frame type (data, remote or both),
		identifier type (11 bit or 29 bit);
		condition =, ≠, >, <; identifier selectable
		from label list
	data setup	data pattern up to 8 byte (hex or binary);
		condition =, \neq , >, <
	event table	search results displayed as tabulated list;
		event navigation
LIN triggering and decoding Bus configuration	version	1.3, 2.x or SAE J602; mixed traffic is
ous configuration	version	
	hit mate	supported
	bit rate	1.2/2.4/4.8/9.6/10.417/19.2 kbps or
		user-selectable in range from 100 bps to
	n a la vita .	5 Mbps
	polarity	active high or active low
F.,	label list	associate frame identifier with symbolic ID
Trigger	source	
	R&S®RTM3002	channel 1, channel 2, logic channels from
	D 9 C®DTM2004	D15 to D0 (requires R&S®RTM-B1 option
	R&S®RTM3004	channel 1, channel 2, channel 3,
		channel 4, logic channels from D15 to D0
		(with R&S®RTM-B1 option)
	trigger events	start of frame (sync break), identifier,
		identifier + data, wakeup frame, error
		condition (any combination of checksum
		error, parity error and sync field error)
	identifier setup	range from 0d to 63d; condition =, ≠, >, <;
		identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary);

Decode	displayed signals	bus signal, logic signal or both
	color coding of bus signal	frame, frame identifier, parity, data
		payload, checksum, error condition
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list, errors highlighted in red; frame navigation; data export as CSV file
Search	search events	frame, error, identifier, identifier + data, identifier + error
	frame event setup	start of frame, wake up
	error event setup	any combination of checksum error, parity error and sync field error
	identifier setup	range from 0d to 63d; condition =, \(\neq \), \(<; \) identifier selectable from label list
	data setup	data pattern up to 8 byte (hex or binary); condition =, \neq , >, <
	event table	search results displayed as tabulated list; event navigation

Audio (I ² S, LJ, RJ, TDM) trigg Bus configuration	source (data, clock, word/sync)					
ous configuration	R&S®RTM3002	channel 1, channel 2, logic channels from				
		D15 to D0 (requires R&S®RTM-B1 option)				
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTM-B1 option)				
	thresholds	per-channel threshold (analog channels), per-group threshold (logic channels), assisted threshold configuration (find level)				
	bit rate	up to 30 Mbps				
	signal type	I ² S standard, left justified, right justified, TDM				
	polarity	data: active high, active low clock: rising edge, falling edge word/sync: normal, inverted				
	word length	2 to 32 bit				
	bit order	most significant bit first (MSBF)				
	Dit Oldei	least significant bit first (MSBF)				
	I ² S specific setup	least significant bit first (LSBF)				
	first channel	loft viabt				
	LJ/RJ specific setup	left, right				
	first channel	left, right				
		0 to 31 bit				
	channel offset	TDM specific setup				
	number of channels	1 to 8				
		2 bit to 32 bit				
	channel length channel offset					
		0 to (channel length – word length) bits				
m'	channel delay	0 to 31 bit				
rigger	trigger events	data, window, word/sync, error condition				
	data setup	define individual value and condition for each audio channel; condition =, ≠, >, <, inside range, outside range, don't care; trigger when "all" or "any" audio channel conditions are met in single audio frame				
	window setup	audio channel setup same as data setup; user-defined window length up to 4 000 000 000 frames				
	word/sync setup	rising edge, falling edge				
ecode	displayed signals	bus signal, stacked bus signal, logic signal				
	color coding of bus signal	color-coded audio channels				
	displayed format of data	hex, signed decimal, binary, ASCII				
	frame table	decode results displayed as tabulated list with timestamp; frame navigation; data export as CSV file				
	track of audio waveform	displays audio channel content as a waveform that is time-correlated to the source signals; user can activate, scale and position each audio channel				

MIL-STD-1553 triggering and decoding		
Protocol configuration	source	
•	R&S [®] RTM3002	channel 1, channel 2, logic channels from D15 to D0 (requires R&S®RTM-B1 option)
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTM-B1 option)
	bit rate	standard bit rate (1 Mbit/s)
	polarity	normal, inverted
	label list	associate frame identifier with symbolic ID
	auto threshold setup	assisted threshold configuration
	timing	max response (4 µs to 200 µs)
Trigger	trigger event setup	sync, word, command word, status word,
1119901		command and data word, error condition
	sync setup	all words, command/status word, data word
	word setup	all words, command word, status word, data word
	command word setup (type: address/word)	RT address (condition =, \neq , \geq , \leq , in range, out of range); direction (T/R); subaddress (condition =, \neq , \geq , \leq , in range, out of range); data word count (condition =, \neq , \geq ,
	command word setup (type: mode code)	≤, in range, out of range) RT address (condition =, ≠, ≥, ≤, in range, out of range); subaddress (0, 31 or either); mode code from labeled drandown list
	status word setup	mode code from labeled dropdown list RT address; status flags (message error, instrumentation, service request,
	command and data word setup	broadcast command, busy, subsystem flag, dynamic bus control, terminal flag) individually configurable (1, 0, don't care) transmission type (BC-RT, RT-BC, BC-RC, mode code); BT address (condition)
		BC, mode code); RT address (condition =, \neq , \geq , \leq , in range, out of range); subaddress (condition =, \neq , \geq , \leq , in range, out of range); data word count (condition =, \neq , \geq , in range, out of range); data pattern up to 4 words long (condition =, \neq , \geq , in range, out of range); payload data index (condition =)
	error condition setup	any combination of sync error, Manchester error, parity error, timing error (see protocol configuration)
Decode	display signals	bus signal; symbolic ID in bus signal when label list in use
	color coding	sync, RT address, subaddress, mode code, status bit field, data, error condition
	displayed format of data	hex, decimal, binary, ASCII
	frame table	decode results displayed as tabulated list, errors highlighted in red; frame navigation; data export as CSV file; column with symbolic ID when label list in use
Search	search events	word, command word, mode code, status word, command and data word, error
	word setup	command, status, data
	command word setup	see trigger settings for "command word setup (type: address/word)"
	mode code setup	see trigger settings for "command word setup (type: mode code)"
	status word setup	see trigger settings for "status word setup"
	command and data word setup	see trigger settings for "command and data word setup"
	T. Control of the Con	add word ootup

ARINC 429 triggering and deco Protocol configuration	source			
J	R&S®RTM3002	channel 1, channel 2, logic channels from D15 to D0 (requires R&S®RTM-B1 option)		
	R&S®RTM3004	channel 1, channel 2, channel 3, channel 4, logic channels from D15 to D0 (with R&S®RTM-B1 option)		
	bit rate	high (100 kbit/s), low (12.5 kbit/s), or user-defined in range 10 kbit/s to 1 Mbit/s		
	polarity	A leg, B leg, normal, inverted		
	label list	associate numeric label with symbolic ID; optional definition of ARINC word format i terms of availability of label-specific SDI and SSM fields		
	auto threshold setup	assisted threshold configuration		
Trigger	trigger event setup	word, label, label and data, error condition transmission interval		
	word setup	word start, word stop		
	label setup	label (condition =, \neq , \geq , \leq , in range, out of range)		
	data setup	data pattern up to 23 bit long (condition = ≠, ≥, ≤, in range, out of range); data bit offset; SDI (00,01,10,11); SSM (00,01,10,11); label list can be used to determine availability of trigger properties SSM and SDI for given label value		
	error condition setup	any combination of coding error, parity error, gap error		
	transmission interval setup	label (condition =); SDI (optional); time interval (condition >, <, in range, out of range)		
Decode	display signals	bus signal, logic signal or both; symbolic ID in bus signal when label list in use		
	color coding	word begin, word end, label, SDI, data, SSM, parity, error		
	displayed format of data	hex, decimal, binary, ASCII		
	frame table	decode results displayed as tabulated list errors highlighted in red; frame navigation data export as CSV file; column with symbolic ID when label list in use		
Search	search events	word, label, label and data, error condition		
	word setup	word start, word stop		
	label setup	see trigger settings for "label setup"		
	data setup	see trigger settings for "data setup"		
	error condition setup	coding error, parity error, gap error, any		

History and segmented memory	y				
Acquisition memory		automatic, predefine	ed, manual		
	automatic	automatic segment	size and numbers	3	
	predefined	defined size and au	defined size and automatic numbers		
	manual	user-defined size ar	user-defined size and numbers		
Memory segmentation	function	memory segments f	memory segments for the acquisition		
	number of segments 3	record length	segments	total memory	
			(up to)	(per channel)	
		5 ksample	34 952	174.8 Msample	
		10 ksample	34 952	349.5 Msample	
		20 ksample	17 476	349.5 Msample	
		50 ksample	6 990	349.5 Msample	
		100 ksample	3 883	388.3 Msample	
		200 ksample	2 056	411.2 Msample	
		500 ksample	852	426 Msample	
		1 Msample	426	426 Msample	
		2 Msample	214	428 Msample	
		5 Msample	85	425 Msample	
		10 Msample	42	420 Msample	
		20 Msample	21	420 Msample	
		40 Msample	10	400 Msample	
		80 Msample	5	400 Msample	
	segmentation is active on a spectrum analysis	all analog and logic chan	nels, protocol ded	coding and	
Fast-segmented mode	visualization; blind time be	tween consecutive acqui	eforms in acquisition memory without interruption due to een consecutive acquisitions less than 200 ns		
I listam, manda	(up to 2 000 000 waveform				
History mode	function		The history mode always provides access to past acquisitions in the segmented memory.		
	timestamp resolution	3.2 ns	3.2 ns		
	history player	replays the recorded adjustable speed; m	nanual next / prev		
		numerical segment			
	analyze options	overlay all segments	overlay all segments, average all segments, envelope all segments		

³ At interleaved mode.

Spectrum analysis and spectrogra	am		
General	additional displays	spectrum traces and/or spectrogram	
Spectrum	sources		
	R&S®RTM3002	channel 1, channel 2	
	R&S [®] RTM3004	channel 1, channel 2, channel 3, channel 4	
	setup parameters	center frequency, frequency span, automatic RBW, resolution bandwidth, gate position, gate width, vertical scale, vertical position, spectrum mode	
	scaling	dBm, dBμV, dBV, V (RMS)	
	span	1 kHz to 1.25 GHz	
	resolution bandwidth	span/10 ≥ RBW ≥ span/1000	
	windows	flat top, Hanning, Hamming, Blackman, rectangular	
	trace types	normal, max. hold, min. hold, average (selectable from 2 to 1024)	
	spectrum mode	optimized for dynamic range of frequency domain (disables time domain for the same channel)	
Spectrogram	color	rainbow, temp. color, monochrome	
Marker	peak marker search	standard search	
		parameter: min. level	
		advanced search	
		parameter: min. level, excursion,	
		maximum width, distance to next peak	
	reference marker	selection via index or frequency range	
	markers on peak	up to 100 markers	
	sources	any spectrum trace	
	table	frequency and magnitude, absolute or relative to reference marker	
	marker result display	indicated at wave form: level, frequency	
Cursor	measurements on spectrum traces	level, frequency, level and frequency, V-marker	
	additional actions for cursor	coupling of cursors, set to trace, set to screen, track scaling, set next and previous peak	
Spectrogram measurements	two time cursor	t1, t2, delta t, total time, relative time between segments	

Power analysis	The Doognott Lice	- and a sale of a DOC®DTM	
General description		s option extends the R&S®RTM firmware with on switched mode power supplies (SMPS) and	
Input	quality	evaluation of power quality at an AC input; measures real power, apparent power, reactive power, power factor and phase angle of power, frequency, crest factor, RMS of voltage and current	
	harmonics	measures up to the 334th harmonic of the incoming line frequency; precompliance checking for IEC 61000-3-2 (A, B, C, D), RTCA DO-160, MIL-STD-1399, max. limit checks	
	inrush current	measures peak inrush current and electrical charge within up to 3 configurable measurement zones to analyze the inrush and post-inrush behavior	
	consumption	long term measurement of consumed power and energy to analyze nonperiodical signals of e.g. standby devices	
Switching/control loop	slew rate	The minimum and maximum slew rate of current or voltage is measured at start and end of the switching cycle.	
	modulation	measures modulation of switching frequency, duty cycle (±) and pulse width	
	dynamic on-resistance	measures resistance of the switching transistor(s) in active state	
Power path	efficiency	measures input and output power to calculate the efficiency of a power device	
	switching loss	measures switching loss and conduction loss of a power device	
	safe operating area (SOA)	checks violation of voltage and current limits in which a power device can operate without damage; current versus voltage view (linear or log); violation mask is user-defined and editable in linear and log-log views; save/load of masks; export of mask violation data	
	turn on/off time	measures relationship between AC and DC current, when turning SMPS off and on	
Output	ripple	measures AC components of output voltage or current, AC RMS, mean, period, frequency, duty cycles, min./max./peak-to-peak amplitude	
	spectrum	FFT analysis of output, measurement of frequency peaks	
	transient response	This measurement captures the device behavior between the event of load changes and stabilization; includes peak (voltage, time), settling time, rise time, overshoot and delay	
Deskew	automated	By using the R&S®RT-ZF20 probe deskew and calibration test fixture and Rohde & Schwarz voltage and current probes, the skew between the signals is compensated automatically.	
Zero offset	automated	automatic compensation of input offset	
Reporting	selected test results from historical measurements in one report. R&S®	Report data can be saved for every measurement. Report generation using user-selected test results from historical and current tests. Put repeated and/or different measurements in one report. R&S®Oscilloscope Report Creator can be downloaded from Rohde & Schwarz website free-of-charge.	

Frequency response analysis -	Bode plot		
Stimulus	frequency mode	single sweep or repeated sweep	
	frequency range	10 Hz to 25 MHz	
	amplitude mode	fixed or amplitude profile	
	amplitude level	20 mV to 10 V into high Z	
		10 mV to 5 V into 50 Ω	
Input and output sources	R&S®RTM3002	channel 1, channel 2	
•	R&S®RTM3004	channel 1, channel 2, channel 3,	
		channel 4	
Number of test points		10 points to 500 points per decade	
Dynamic range		typ. > 70 dB based on 0 dBm	
		(630 mV (V_{pp}) into 50 Ω,	
		gain noise < 1 dB, phase noise < 5°)	
Measurement		dual pair of tracking gain and phase	
		cursors	
Diagram types	manually changeable vertical window size	parallel display of result window and input	
		and output signal view	
Result table		navigation and export functions	
Scaling	during and after test	auto-scale and manual scaling and	
		positioning	

Ordering information

Designation	Туре	Order No.
Choose your R&S®RTM3000 base model		
Oscilloscope, 100 MHz, 2 channels	R&S®RTM3002	1335.8794.02
Oscilloscope, 100 MHz, 4 channels	R&S®RTM3004	1335.8794.04
Base unit (including standard accessories: 500 MHz passive probe pe	r channel, power cord)	
Choose your bandwidth upgrade	DAG@DTM DAGG	1005 0000 00
Upgrade of R&S®RTM3002 oscilloscopes to 200 MHz bandwidth	R&S®RTM-B222	1335.9003.02
Upgrade of R&S®RTM3002 oscilloscopes to 350 MHz bandwidth	R&S®RTM-B223	1335.9010.02
Upgrade of R&S®RTM3002 oscilloscopes to 500 MHz bandwidth	R&S [®] RTM-B225 R&S [®] RTM-B2210	1335.9026.02
Upgrade of R&S®RTM3002 oscilloscopes to 1 GHz bandwidth		1335.9032.02
Upgrade of R&S®RTM3004 oscilloscopes to 200 MHz bandwidth Upgrade of R&S®RTM3004 oscilloscopes to 350 MHz bandwidth	R&S [®] RTM-B242 R&S [®] RTM-B243	1335.9049.02
Upgrade of R&S®RTM3004 oscilloscopes to 550 MHz bandwidth	R&S®RTM-B245	1335.9055.02 1335.9061.02
Upgrade of R&S®RTM3004 oscilloscopes to 300 MHz bandwidth	R&S®RTM-B2410	1335.9078.02
Choose your options	R&S RTW-B2410	1333.9076.02
Vixed signal upgrade for non-MSO models, 400 MHz	R&S®RTM-B1	1335.8988.02
Arbitrary waveform and 4-bit pattern generator	R&S®RTM-B6	1335.8994.02
² C/SPI serial triggering and decoding	R&S®RTM-K1	1335.8807.02
JART/RS-232/RS-422/RS-485 serial triggering and decoding	R&S®RTM-K2	1335.8813.02
CAN/LIN serial triggering and decoding	R&S®RTM-K3	1335.8820.02
Audio (I ² S, LJ, RJ, TDM) triggering and decoding	R&S®RTM-K5	1335.8842.02
MIL-STD-1553 serial triggering and decoding	R&S®RTM-K6	1335.8859.02
ARINC 429 serial triggering and decoding	R&S®RTM-K7	1335.8865.02
History and segmented memory	R&S®RTM-K15	1335.8907.02
Spectrum analysis and spectrogram ⁴	R&S®RTM-K18	1335.8913.02
Power analysis	R&S®RTM-K31	1335.8920.02
Frequency response analysis (Bode plot)	R&S®RTM-K36	1335.9178.02
Application bundle ⁵ , consists of the following options: R&S [®] RTM-K1, R&S [®] RTM-K2, R&S [®] RTM-K3, R&S [®] RTM-K5, R&S [®] RTM-K6, R&S [®] RTM-K7, R&S [®] RTM-K15, R&S [®] RTM-K18,	R&S®RTM-PK1	1335.8942.02
R&S®RTM-K31, R&S®RTM-K36, R&S®RTM-B6 Application bundle ⁶ , consists of the following options:	R&S®RTM-PK1US	1335.9190.02
R&S®RTM-K1, R&S®RTM-K2, R&S®RTM-K3, R&S®RTM-K5, R&S®RTM-K6, R&S®RTM-K7, R&S®RTM-K15, R&S®RTM-K31,	Kas Krivi-i Kros	1333.9190.02
R&S®RTM-K36, R&S®RTM-B6		
Choose your additional probes		
Single-ended passive probes		
500 MHz, 10 MΩ, 10:1, 300 V, 10 pF, 5 mm	R&S®RT-ZP05S	1333.2401.02
500 MHz, 10 MΩ, 10:1, 400 V, 9.5 pF, 2.5 mm	R&S®RT-ZP10	1409.7550.00
38 MHz, 1 MΩ, 1:1, 55 V, 39 pF, 2.5 mm	R&S®RT-ZP1X	1333.1370.02
Active broadband probes: single-ended		
1.0 GHz, 10:1, 1 MΩ, BNC interface	R&S®RT-ZS10L	1333.0815.02
1.0 GHz, active, 1 MΩ, Rohde & Schwarz probe interface	R&S®RT-ZS10E	1418.7007.02
I.0 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface	R&S [®] RT-ZS10	1410.4080.02
.5 GHz, active, 1 MΩ, R&S®ProbeMeter, micro button,	R&S®RT-ZS20	1410.3502.02
Rohde & Schwarz probe interface Active broadband probes: differential		
1.0 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button,	R&S®RT-ZD10	1410.4715.02
ncl. 10:1 external attenuator, 1 MΩ, 70 V DC, 46 V AC (peak),	100 11-2010	1410.4710.02
Rohde & Schwarz probe interface I.5 GHz, active, differential, 1 MΩ, R&S®ProbeMeter, micro button, Rohde & Schwarz probe interface	R&S®RT-ZD20	1410.4409.02
Power rail probe	1	I .
2.0 GHz, 1:1, 50 k Ω , ±0.85 V, ±60 V offset, Rohde & Schwarz probe nterface	R&S®RT-ZPR20	1800.5006.02
High voltage single-ended passive probes		I
	R&S®RT-7H03	1333 0873 02
250 MHz, 100:1, 100 MΩ, 850 V, 6.5 pF 400 MHz, 100:1, 50 MΩ, 1000 V, 7.5 pF	R&S [®] RT-ZH03 R&S [®] RT-ZH10	1333.0873.02 1409.7720.02

⁴ The R&S[®]RTM-K18 option is not distributed in North America.

 $^{^{\}rm 5}$ The R&S $^{\rm @}$ RTM-PK1 option is not distributed in North America.

⁶ The R&S®RTM-PK1US option is only distributed in North America.

Designation	Туре	Order No.
High voltage probes: differential		
25 MHz, 20:1/200:1, 4 MΩ, 1.4 kV (CAT III), BNC interface	R&S®RT-ZD002	1337.9700.02
25 MHz, 10:1/100:14 MΩ, 700 V (CAT II), BNC interface	R&S®RT-ZD003	1337.9800.02
100 MHz, 8 MΩ, 1 kV (RMS) (CAT III), BNC interface	R&S®RT-ZD01	1422.0703.02
200 MHz, 10:1, ±20 V, BNC interface	R&S®RT-ZD02	1333.0821.02
800 MHz, 10:1, 200 kΩ, ±15 V, BNC interface	R&S®RT-ZD08	1333.0838.02
200 MHz, 250:1/25:1, 5 MΩ, 750 V (peak), 300 V CAT III,	R&S®RT-ZHD07	1800.2307.02
Rohde & Schwarz probe interface		
100 MHz, 500:1/50:1, 10 M Ω , 1500 V (peak), 1000 V CAT III,	R&S®RT-ZHD15	1800.2107.02
Rohde & Schwarz probe interface	D 0 00 D T TU D 10	
200 MHz, 500:1/50:1, 10 MΩ, 1500 V (peak), 1000 V CAT III,	R&S®RT-ZHD16	1800.2207.02
Rohde & Schwarz probe interface	DA ORDT ZUDOO	4000 0007 00
100 MHz, 1000:1/100:1, 40 MΩ, 6000 V (peak), 1000 V CAT III,	R&S®RT-ZHD60	1800.2007.02
Rohde & Schwarz probe interface Current probes		
20 kHz, AC/DC, 0.01 V/A and 0.001 V/A, ±200 A and ±2000 A,	R&S®RT-ZC02	1222 0850 02
BNC interface	R&3°R1-2C02	1333.0850.02
100 kHz, AC/DC, 0.1 V/A, 30 A, BNC interface	R&S®RT-ZC03	1333.0844.02
2 MHz, AC/DC, 0.1 V/A, 500 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC05B	1409.8204.02
interface	100 101 2000D	1403.0204.02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), BNC interface	R&S®RT-ZC10	1409.7750K02
10 MHz, AC/DC, 0.01 V/A, 150 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC10B	1409.8210.02
interface		
50 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC15B	1409.8227.02
interface		
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), BNC interface	R&S®RT-ZC20	1409.7766K02
100 MHz, AC/DC, 0.1 V/A, 30 A (RMS), Rohde & Schwarz probe	R&S®RT-ZC20B	1409.8233.02
interface		
120 MHz, AC/DC, 1 V/A, 5 A (RMS), BNC interface	R&S®RT-ZC30	1409.7772K02
EMC near-field probes		
Probe set for E and H near-field measurements, 30 MHz to 3 GHz	R&S®HZ-15	1147.2736.02
Logic probes		
400 MHz logic probe, 8 channels	R&S®RT-ZL04	1333.0721.02
Probe accessories		
Probe power supply for R&S®RT-ZC10/20/30	R&S®RT-ZA13	1409.7789.02
External attenuator 10:1, 2.0 GHz, 1.3 pF, 60 V DC, 42.4 V AC (peak)	R&S®RT-ZA15	1410.4744.02
for R&S®RT-ZD20/30 probes	D000DT 7440	
Probe pouch	R&S®RT-ZA19	
Power deskew and calibration test fixture	R&S®RT-ZF20	1800.0004.02
3D positioner with central tensioning knob for easy clamping and	R&S®RT-ZA1P	1326.3641.02
positioning of probes (span width: 200 mm, clamping range: 15 mm)		
Choose your accessories	R&S®RTB-Z1	1222 1720 02
Front cover	R&S®RTB-Z1	1333.1728.02
Soft bag		1333.1734.02
Transit case Peolymount kit	R&S®RTB-Z4	1335.9290.02
Rackmount kit	R&S®ZZA-RTB2K	1333.1728.02

Warranty		
Base unit		3 years
All other items ⁷		1 year
Options		
Extended warranty, one year	R&S®WE1	Please contact your local
Extended warranty, two years	R&S®WE2	Rohde & Schwarz sales
Extended warranty with calibration coverage, one year	R&S®CW1	office.
Extended warranty with calibration coverage, two years	R&S®CW2	
Extended warranty with accredited calibration coverage,	R&S®AW1	
one year		
Extended warranty with accredited calibration coverage,	R&S®AW2	
two years		

Extended warranty with a term of one and two years (WE1 and WE2)

Repairs carried out during the contract term are free of charge ⁸. Necessary calibration and adjustments carried out during repairs are also covered.

Extended warranty with calibration (CW1 and CW2)

Enhance your extended warranty by adding calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated, inspected and maintained during the term of the contract. It includes all repairs ⁸ and calibration at the recommended intervals as well as any calibration carried out during repairs or option upgrades.

Extended warranty with accredited calibration (AW1 and AW2)

Enhance your extended warranty by adding accredited calibration coverage at a package price. This package ensures that your Rohde & Schwarz product is regularly calibrated under accreditation, inspected and maintained during the term of the contract. It includes all repairs ⁸ and accredited calibration at the recommended intervals as well as any accredited calibration carried out during repairs or option upgrades.

⁷ For options that are installed, the remaining base unit warranty applies if longer than 1 year. Exception: all batteries have a 1 year warranty.

⁸ Excluding defects caused by incorrect operation or handling and force majeure. Wear-and-tear parts are not included.

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PD 5214.9144.32 | Version 06.00 | May 2019 (as

R&S®RTM3000 Oscilloscope

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